

# U74AHCT3G06

CMOS IC

## INVERTER WITH OPEN-DRAIN OUTPUT

### ■ DESCRIPTION

The **U74AHCT3G06** is a high-speed Si-gate CMOS device which provides three inverting buffers with open-drain outputs. For digital operation this device must have a pull-up resistor to establish a logic HIGH-level.

The **U74AHCT3G06** is compatible of TTL input switching levels and has supply voltage range from 4.5V to 5.5V.



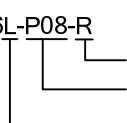
TSSOP-8

### ■ FEATURES

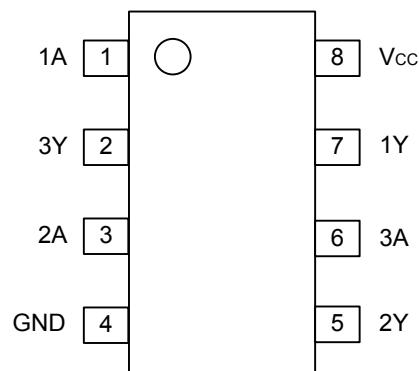
- \* Low power supply 1.0 $\mu$ A at 5.5V
- \* Up to 5.5V inputs accept voltages
- \* Low power dissipation
- \* Balanced propagation delays
- \* High noise immunity
- \* Output capability standard (open drain)

### ■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74AHCT3G06L-P08-R	U74AHCT3G06G-P08-R	TSSOP-8	Tape Reel
U74AHCT3G06L-P08-T	U74AHCT3G06G-P08-T	TSSOP-8	Tube

U74AHCT3G06L-P08-R 	(1)Packing Type (2)Package Type (3)Lead Free	(1) R: Tape Reel, T: Tube (2) P08: TSSOP-8 (3) G: Halogen Free, L: Lead Free
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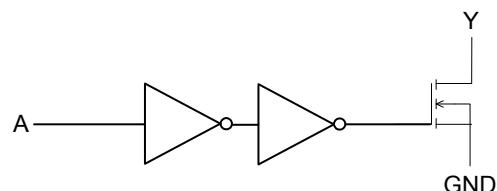
■ PIN CONFIGURATION



■ FUNCTION TABLE (each gate)

INPUT(A)	OUTPUT(Y)
L	Z
H	L

■ LOGIC DIAGRAM (each gate)



■ ABSOLUTE MAXIMUM RATING (unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V <sub>CC</sub>	-0.5 ~ 7.0	V
Input Voltage	V <sub>IN</sub>	-0.5 ~ 7.0	V
Output Voltage	V <sub>OUT</sub>	-0.5 ~ 7.0(active mode) -0.5 ~ 7.0(high-impedance mode)	V
Output Voltage			
V <sub>CC</sub> or GND Current	I <sub>CC</sub>	±75	mA
Output Current	I <sub>OUT</sub>	±25	mA
Input Clamp Current	I <sub>IK</sub>	-20	mA
Output Clamp Current	I <sub>OUT</sub>	±20	mA
Operating Temperature	T <sub>OPR</sub>	-40 ~ + 85	
Storage Temperature	T <sub>STG</sub>	-65 ~ + 150	

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V <sub>CC</sub>		4.5	5.0	5.5	V
Input Voltage	V <sub>IN</sub>		0		5.5	V
Output Voltage	V <sub>OUT</sub>	Active mode High-impedance mode	0 0		V <sub>CC</sub> 6.0	V
Input Rise or Fall Times	t <sub>R</sub> , t <sub>F</sub>	V <sub>CC</sub> = 5.0 ± 0.5V			20	ns/V

■ ELECTRICAL CHARACTERISTICS(T<sub>A</sub>=25 °C)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V <sub>IH</sub>	V <sub>CC</sub> = 4.5 V to 5.5 V	2.0			V
Low-Level Input Voltage	V <sub>IL</sub>	V <sub>CC</sub> = 4.5 V to 5.5 V			0.8	V
Low-Level Output Voltage	V <sub>OL</sub>	V <sub>CC</sub> = 4.5V, V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>O</sub> = 50 μA I <sub>O</sub> = 8.0 mA	0 0.36	0.1	V
Input Leakage Current	I <sub>I(LEAK)</sub>	V <sub>I</sub> = 5.5V or GND, V <sub>CC</sub> = 0V to 5.5V			0.1	μA
3-State output OFF-State Current	I <sub>OZ</sub>	V <sub>CC</sub> = 5.5V, V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> , V <sub>O</sub> = V <sub>CC</sub> or GND			±.025	μA
Quiescent Supply Current	I <sub>CC</sub>	V <sub>CC</sub> = 5.5V, V <sub>I</sub> = V <sub>CC</sub> or GND, I <sub>O</sub> = 0			1.0	μA
Additional Quiescent Supply Current	ΔI <sub>CC</sub>	V <sub>CC</sub> = 5.5V, One input at 3.4V, Other inputs at V <sub>CC</sub> or GND, I <sub>OUT</sub> = 0			1.35	mA
Input Capacitance	C <sub>IN</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND			1.5	pF

■ SWITCHING CHARACTERISTICS ( $T_A=25^\circ\text{C}$ ,  $t_R = t_F \leq 3.0 \text{ ns}$ )

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Propagation Delay from Input (A) to Output(Y)	$t_{PZL}$	$V_{CC} \text{ 4.5V to 5.5V}$	$C_L \text{ 15pF}$	-	3.0	5.3	ns
	$t_{PLZ}$		$C_L \text{ 15pF}$	-	3.2	4.6	
	$t_{PZL}$	$V_{CC} \text{ 4.5V to 5.5V}$	$C_L \text{ 50pF}$	-	4.2	7.5	ns
	$t_{PLZ}$		$C_L \text{ 50pF}$	-	4.5	7.0	

■ OPERATING CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ )

PARAMETER	SYMBOL	TEST CONDITIONS	TYP	UNIT
Power Dissipation Capacitance	$C_{PD}$	$C_L=50\text{pF}, f=1\text{MHz}$ (Note1, 2)	4.5	pF

Notes

1.  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum(C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

$f_i$  = input frequency in MHz;

$f_o$  = output frequency in MHz;

$C_L$  = output load capacitance in pF;

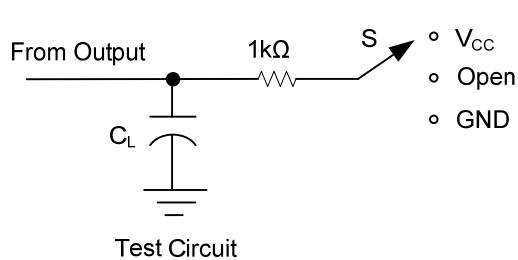
$V_{CC}$  = supply voltage in Volts;

N = number of inputs switching;

$\sum(C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.

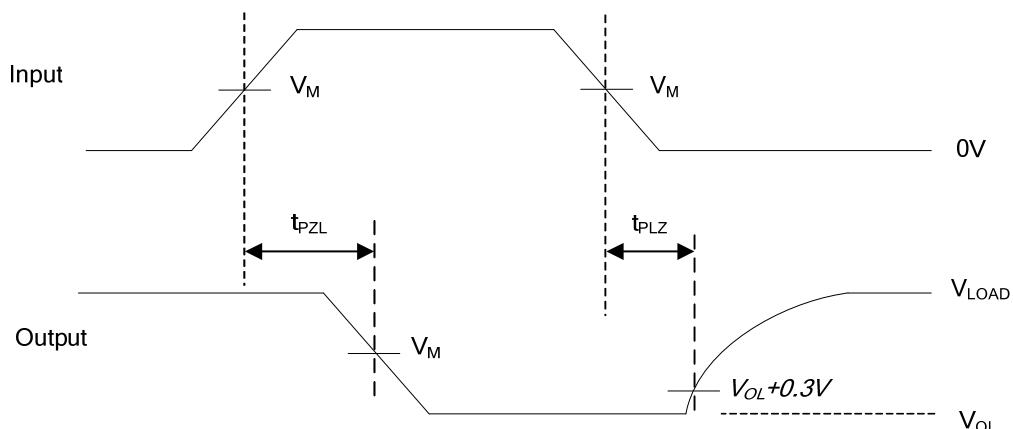
2. The condition is  $V_I = \text{GND}$  to  $V_{CC}$ .

■ TEST CIRCUIT AND WAVEFORMS



TEST	S
$t_{PLH}/t_{PHL}$	Open
$t_{PZH}/t_{PZL}$	GND
$t_{PLZ}/t_{PZL}$	$V_{CC}$

$V_I$	$V_M$	$V_M$
GND to $V_{CC}$	50% $V_{CC}$	50% $V_{CC}$



Voltage Waveforms Enable and Disable Times

Note:  $C_L$  includes probe and jig capacitance.  
 $P_{RR} \leq 1\text{MHz}$ ,  $Z_0 = 50\Omega$ ,  $t_R \leq 3\text{ns}$ ,  $t_F \leq 3\text{ns}$ .

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